



Hearing Aid Compatibility

FCC 47 CFR section 20.19 Test Report

Dual-Band CDMA Cellular Phone with Bluetooth

FCC ID: **OVFE1000-255**

Model: **E1000**

STATEMENT OF CERTIFICATION

The data, data evaluation and equipment configuration represented herein are a true and accurate representation of the measurements of the sample's HAC RF emissions characteristics as of the dates and at the times of the test under the conditions herein specified.

STATEMENT OF COMPLIANCE

This product was tested in accordance with the measurement procedures specified in ANSI C63.19-2006 and has been shown to be capable of compliance with the technical requirements of FCC 47 CFR section 20.19.

Test Location:	Kyocera Wireless Corp. 10300 Campus Point Drive, San Diego, CA 92121 USA				
Test performed by:	Yohannes Ghebrehiwet Test Technician Date of Test: 5/1/07 – 5/7/07				
Report Prepared by:	Ngoc-Thi Nguyen Regulatory Engineer	Date of Report:	5/8/07 – 5/10/07		
Report Reviewed by:	C. K. Li Principal Hardware Engineer	Date of Review:	5/10/07		





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1 Introduction

This test report describes the Hearing Aid Compatibility (HAC) measurement of a wireless portable device manufactured by Kyocera Wireless Corp. (KWC). These measurements were performed for compliance with the rules and regulations of the U.S. Federal Communications Commission (FCC). The testing was performed in accordance with ANSI C63.19-2006.

This report covers test and data on:

X	RF Emissions	ANSI C63.19 Clause 4
	T-Coil	ANSI C63.19 Clause 6

2 Equipment Under Test (EUT)

Product:	Dual-Band CDMA Cellula	ar Phone with Bluetooth		
FCC ID:	OVFE1000-255			
Model Number:	E1000	E1000		
EUT Serial Number:	FFE10000001359			
Type:	[] Prototype, [X] Pre-Pr	oduction, [] Production		
Device Category:	Portable			
RF Exposure Environment:	General Population / Uncontrolled			
Antenna:	Internal Antenna			
Detachable Antenna:	No			
External Input:	Audio/Digital Data			
Quantity:	Quantity production is pla	nned		
Modes:	800 CDMA 1900 CDMA			
Multiple Access Scheme:	CDMA CDMA			
TX Frequency (MHz):	824 – 849 1850 - 1910			
Rated RF Conducted Output Power	24.0 23			
(dBm)				

3 Summary of Test Results

ANSI C63.19 (2005)				
Section 4 RF Emissions				
Test Test Results Overall Category				
E-Field Emissions	M4	M4		
H-Field Emissions	M4	1414		

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4 Test conditions

4.1 Ambient Conditions

All tests were performed under the following environmental conditions:

Ambient Temperature:	23 ± 2 Degrees C
Tissue simulating liquid temperature:	22 ± 1 Degrees C
Relative Humidity (RH):	0% <rh 80%<="" <="" th=""></rh>
Atmospheric Pressure:	101.3kPa + 10 to -5kPa

4.2 RF characteristics of the test site

All HAC measurements were performed inside a shielded room that provide isolation from external EM fields, with the RF ambient at least 20 dB below the intended measurement limits.

4.3 Test Signal, Frequencies and Output Power

Peak and Average conducted power were measured for each mode for comparison. RC3 SO55 was chosen for worst-case power configuration.

CONFIGURATION	CONDUCTED POWER (dBm)				
	CDMA 800		CDMA	\ 1900	
	Ch 383		Ch 600		
	Peak	Average	Peak	Average	
SO2, RC1 Full Rate	28.73	24.35	27.54	22.95	
SO2, RC3 Full Rate	28.37	24.24	26.98	22.94	
SO55, RC1 Full Rate	28.59	24.33	27.34	22.91	
SO55, RC3 Full Rate	28.46	24.38	26.91	22.97	
TDSO SO32, RC3 (FCH +SCH) Full Rate	28.32	24.19	27.94	22.93	
TDSO SO32, RC3 (-SCH) Full Rate	28.33	24.08	27.06	22.42	





During tests, the EUT was put in in-call mode and controlled by a CDMA simulator to generate the required signal and power using the configuration below.

Protocol:	6 (IS-2000)
Radio Configuration:	3
Power Control:	All Up Bits
Service Option:	55
Data Rate:	Full

In all operating modes, the phone was set to rate maximum RF power level and the measurements were performed on low, mid and high channels.

The measurement system measures power drift during HAC testing by comparing E/H-field in the same location at the beginning and at the end of measurement. These records were used to monitor stability of power output during tests. Conducted RF power measurements were also performed before and after each HAC measurements to confirm the output power.

4.4 EUT Operating Conditions

The EUT was tested with the following configurations and conditions, if applicable:

- X Fully charged standard as supplied with the handset
- X At ear use position.
- Both retracted and extended antenna positions
- X Back-light tested ON and OFF
- X Simultaneous transmission with Bluetooth transmitter ON

5 Description of the test equipment

5.1 Test Equipment Used

Below is a list of the calibrated equipment used for the measurements:

Description	Manufacturer	Model Number	Serial Number	Cal Due Date
Power Meter	Giga-tronics	8541C	1835328	04/05/08
Signal Generator	Hewlett Packard	E4421B	US38440337	06/20/07
Radio Communication Tester	Aglient	8960	US41070147	06/02/07
Data Acq	Speag	DAE4	527	09/19/07
E-field Probe	Speag	ER3DV6	2341	04/20/08
H-field Probe	Speag	H3DV5	6029	06/22/07
Dipole Antenna (835MHz)	Speag	CD835V3	1020	04/26/09
Dipole Antenna (1880MHz)	Speag	CD1880V3	1015	04/26/09
Spectrum Analyzer	Hewlett Packard	8594E	3710A04845	07/14/08

The calibration certificates of E-field and H-field probes are attached in Appendix A.

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5.2 Near Field Measurement System

The measurements were performed with Dasy4 automated near-field scanning system comprised of high precision robot, robot controller, computer, near-field probe, probe alignment sensor, non-conductive phone positioner, Test Arch and software extension. The overall expanded uncertainty (K=2) of the measurement system is $\pm 10.9\%$ and $\pm 14.7\%$ for H-field and E-field resp. The measurement uncertainty budget is given in section 6.

5.3 Isotropic E-Field Probe

Model	■ ER3DV6			
Construction	 One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether) 			
Calibration	■ In air from 100 MHz to 3.0 GHz (absolute accuracy ± 6%; k=2)			
Frequency	100MHz to 6 GHzLinearity: ± 0.2dB (100MHz to 3GHz)			
Directivity	± 0.2 dB in air (rotation around probe axis)			
	± 0.4 dB in air (rotation normal to probe axis)			
Dynamic Range	■ 2 V/m to > 1000 V/m			
	■ Linearity: ± 0.2 dB			
Dimensions	Overall length: 330 mm (Tip: 16 mm)			
	■ Tip diameter: 8 mm (Body: 12 mm)			
	 Distance from probe tip to dipole centers: 2.5 mm 			
Application	 General near-field measurements up to 6 GHz 			
	 Field component measurements 			
	 Fast automatic scanning in phantoms 			





5.4 Isotropic H-Field Probe

Model	■ H3DV5		
Construction	 Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether) 		
Frequency	 200 MHz to 3 GHz (± 6.0%, k=2); Output linearized 		
Directivity	■ ± 0.25 dB (spherical isotropy error)		
Dynamic Range	■ 10 mA/m to 2 A/m at 1 GHz		
E-Field Interference	< 10% at 3 GHz (for plane wave)		
Dimensions	Overall length: 330 mm (Tip: 40 mm)		
	■ Tip diameter: 6 mm (Body: 12 mm)		
	 Distance from probe tip to dipole centers: 3 mm 		
Application	 General magnetic near-field measurements up to 3 GHz 		
	Field component measurements		
	Surface current measurements		
	Measurements in air or liquids		
	 Low interaction with the measured field 		



6 System Validation

The manufacturer calibrates the probes annually. The HAC measurements of the device were done within 24 hours of system accuracy verification, which was done using calibration dipoles. Unmodulated continuous wave of power level of 20dBm was supplied to a dipole antenna placed under Test Arch. The measurement probes are positioned over the illuminated dipole at 10mm distance from the top surface of the dipole element to the calibration reference point of the sensor, defined by the probe manufacturer.

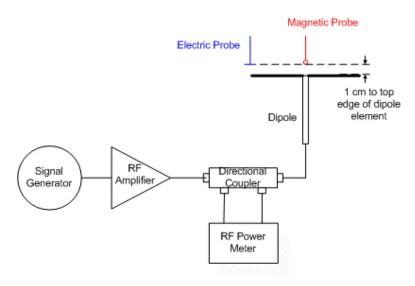


Figure 6 - System Check Setup

The length of the dipole was scanned with both E and H-field probes and the maximum values for each were recorded. The validation results are in the table below and printouts of the validation test are attached in Appendix B. All the measured parameters were within the specification.

Freq. (MHz)	Parameter	Target, SPEAG	Measured	Delta (%)	Limit (%)	Test date
836.49	E dB(V/m)	166.4	179.70	7.99	± 25	5/01/07
	H dB(A/m)	0.450	0.4747	5.49	± 25	5/01/07
1880	E dB(V/m)	140.0	147.80	5.57	± 25	5/01/07
	H dB(A/m)	0.458	0.4928	7.60	± 25	5/01/07

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7 Description Of The Test Procedure

The device was positioned and setup according to ANSI C63.19-2006.

7.1 Test Positions

The device was placed on a non-conductive phone positioner under the Test Arch.

7.2 RF Emission Measurements Reference and Plane

Figure 7.2 illustrates the references and reference plane that shall be used in the EUT emissions measurement:

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer (speaker) of the EUT.
- The grid is in a reference plane, which is defined as the planar area that contains the highest point in the area of the phone that normally rests against the user's ear. It is parallel to the centerline of the receiver of the EUT and is defined by the points of the receiver-end of the EUT, which, in normal handset use, rest against the ear.
- The measurement plane is parallel to, and 1.0 cm in front of, the reference plane.

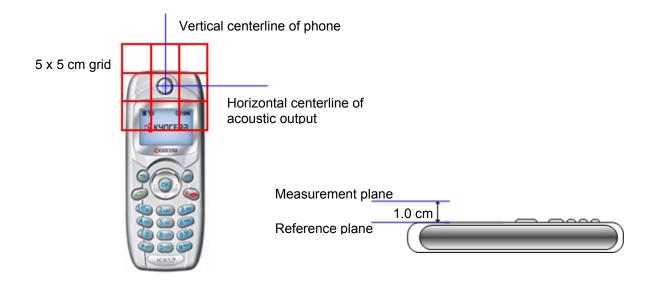


Figure 7.2 – Measurement Reference and Plane



7.3 RF Emissions Measurement Procedures

Figure 7.6 shows the near field emission measurement flowchart:

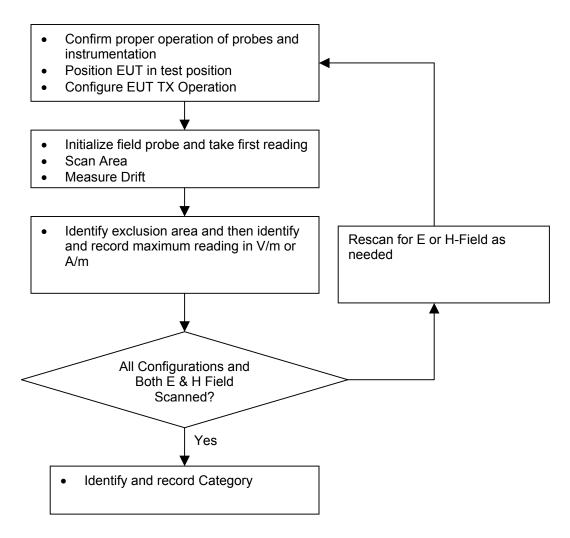


Figure 7.3 - Near field emission measurement flowchart

- 1. The center of the probe was scanning to the edges of the grid. Accordingly the total area covered by the outside edge of the probe was the 5 cm by 5 cm area, increased by half (½) the probe diameter on all sides.
- 2. The nearest point on the probe measurement element(s) was held 1.0 cm from the EUT reference plane.
- 3. The probe element is that portion of the probe that is designed to receive and sense the field being measured.
- 4. The physical body of the probe housing was not used when setting this 1.0 cm distance as this would place the sensing elements at an indeterminate distance from the reference plane.
- 5. The step size of the scan is set to 5 mm or less.
- 6. Up to three blocks were excluded for each field measurement.
 - The center block containing the EUT output was not excluded.
 - A maximum of five blocks were excluded for both E- and H-field measurements for the EUT
 output being measured. Stated differently, the center sub-grid or block and 3 other blocks were
 common to both the E- and H-field measurements for a given grid.





7.4 Probe Modulation Factor (PMF)

7.4.1 Measurement Procedures

A calibration was made of the modulation response of the probe and its instrumentation chain. This calibration was performed with the field probe, attached to its instrumentation. The response of the probe system to a CW field at the frequency of interest is compared to its response to a modulated signal with equal peak amplitude to that of a CW signal. The field level of the test signals shall be more than 10 dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated reading was applied to the DUT measurements. The measurement procedures are as following:

- 1. Fix the field probe in a set location relative to the dipole antenna, as illustrated in Figure 7.4.
- 2. Setup the wireless device (EUT) with intended signal at the intended measurement frequency.
- 3. Record the reading of the probe measurement system.
- 4. Replace the wireless device with a RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
- 5. Set the peak power of the unmodulated signal to equal that recorded from the wireless device
- 6. Record the reading of the probe measurement system of the unmodulated CW signal.
- 7. The ratio of probe reading (CW) in step 6 to the probe reading (EUT) in step 3 is the modulation factor.

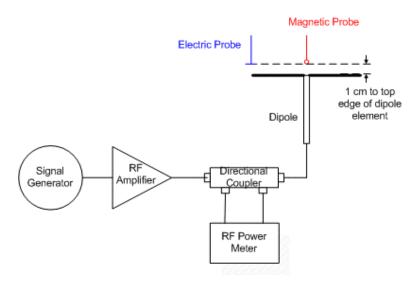


Figure 7.4 - Probe Modulation Setup

The modulation factors obtained by above method shall be applied to readings taken of the actual WD, in order to obtain an accurate peak field reading.



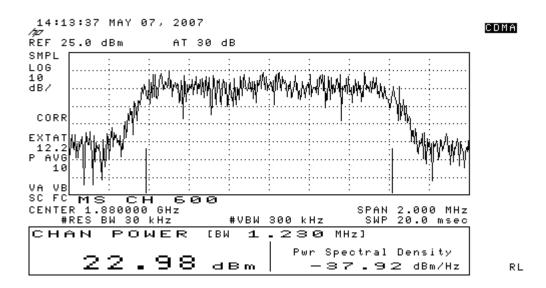


7.4.2 PMF Test Results

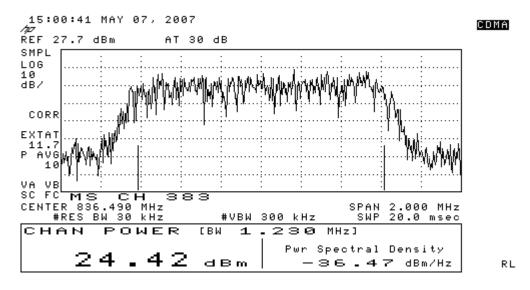
		E-F	ield		
Frequency (MHz)	Peak Power (dBm)	Protocol	Protocol Reading (V/m)	PMF Ratio	PMF (dB)
	24.45	CW	175.9		
836.49	24.42	CDMA	177.1	0.99	-0.1
	24.43	AM	109.5	1.61	4.1
	22.96	CW	103.9		
1880	22.98	CDMA	105.8	0.98	-0.16
	22.98	AM	65.77	1.58	3.97
		H-F	ield		
Frequency (MHz)	Peak Power (dBm)	H-F	Protocol Reading (A/m)	PMF Ratio	PMF (dB)
			Protocol	PMF Ratio	PMF (dB)
	(dBm)	Protocol	Protocol Reading (A/m)	PMF Ratio 0.97	PMF (dB)
(MHz)	(dBm) 24.43	Protocol CW	Protocol Reading (A/m) 0.498		
(MHz)	(dBm) 24.43 24.40	Protocol CW CDMA	Protocol Reading (A/m) 0.498 0.516	0.97	-0.3
(MHz)	(dBm) 24.43 24.40 24.43	Protocol CW CDMA AM	Protocol Reading (A/m) 0.498 0.516 0.324	0.97	-0.3



7.4.3 PMF Peak Power Measurement Plots

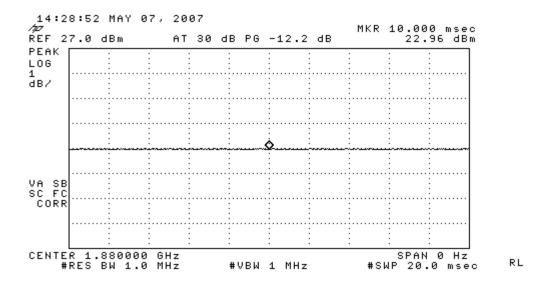


CDMA-1900

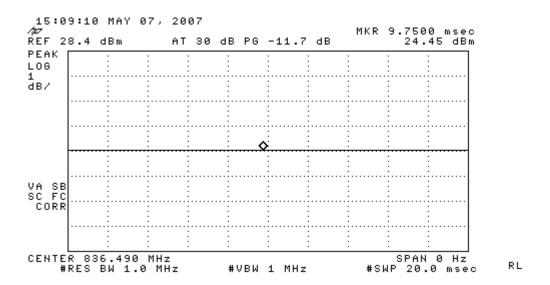


CDMA-800



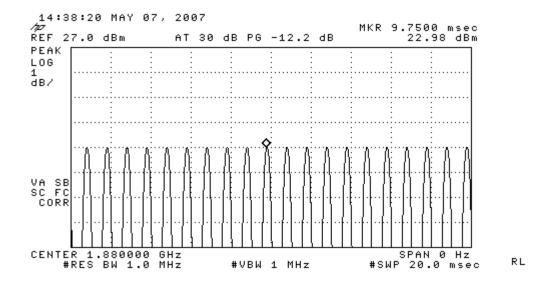


CW -1900

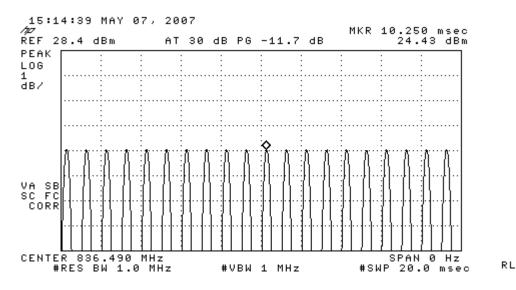


CW -800





80% AM -1900



80% AM -800

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8 Emission Data Extraction and Post processing

At the end of the measurements, the DASY4 system automatically evaluates the slot-averaged results, exclusion of the three highest sub-grid, application of the AWF factor per ANSI-C63.19 requirements.

The following AWF factors were used for the standard transmission protocols:

Standard	Technology	AWF
TIA/EIA/IS-2000	CDMA	0
TIA/EIA-136	TDMA (50 Hz)	0
J-STD-007	GSM (217)	-5
T1/T1P1/3GPP	UMTS (WCDMA)	0
iDEN [™]	TDMA(22 and 11 Hz)	0

Table 7.5a - Articulation Weighting Factor (AWF)

All DASY4 measurements are in RMS values. The Dasy4 system incorporates the crest factor of the signal in the computation of the RMS values. Although the software also has the capability to estimate the peak field by applying a square root of the crest factor value to the readings, the probe modulation factor was applied manually instead per ANSI C63.19 in the measurement tables in this report using equation:

Peak Field = (DASY4 reading) x PMF

where DASY4 reading = measurement from DASY4 in V/m or A/m PMF = Probe Modulation Factor in linear unit



9 Measurement Uncertainty

Table 9 shows the uncertainty budget for HAC free field assessment according to ANSI C63.19-2006. The budget is valid for the frequency range 800 MHz - 3 GHz and represents a worst-case analysis. For specific tests and configurations, the uncertainty could be smaller.

Uncertainty Description	Uncert. Value (± %)	Prob. Dist.	Div.	C _i (E)	C _i (H)	Stand. Uncert (E) (±%)	Stand. Uncert (H) (±%)
Measurement system							
Probe calibration	5.1	N	1	1	1	5.1	5.1
Axial isotropy of the probe	4.7	R	√3	1	1	2.7	2.7
Sensor displacement	16.5	R	√3	1	0.145	9.5	1.4
Boundary effects	2.4	R	√3	1	1	1.4	1.4
Probe linearity	4.7	R	√3	1	1	2.7	2.7
Scaling to Peak Envelope Power	2.0	R	√3	1	1	1.2	1.2
System Detection limit	1.0	R	√3	1	1	0.6	0.6
Readout electronics	0.3	N	1	1	1	0.3	0.3
Response time	8.0	R	√3	1	1	0.5	0.5
Integration time	2.6	R	√3	1	1	1.5	1.5
RF ambient conditions	3.0	R	√3	1	1	1.7	1.7
RF Reflections	12	R	√3	1	1	6.9	6.9
Probe Positioner	1.2	R	√3	1	0.67	0.7	0.5
Probe positioning	4.7	R	√3	1	0.67	2.7	1.8
Extrap. and integration	1.0	R	√3	1	1	0.6	0.6
Test Sample Related							
Device positioning vertical	4.7	R	√3	1	0.67	2.7	1.8
Device Positioning Lateral	1.0	R	√3	1	1	0.6	0.6
Device Holder and Phantom	2.4	R	√3	1	1	1.4	1.4
Power drift	5.0	R	√3	1	1	2.9	2.9
Phantom and Setup Related							
Phantom thickness	2.4	R	√3	1	0.67	1.4	0.9
	С	ombined	d Standa	ard Unce	ertainty:	14.7	10.9
Exten	ded Standa	ard Unce	ertainty	on Powe	er (k=2):	29.4	21.8
Exte	nded Stan	dard Und	ertainty	on Fiel	d (k=2):	14.7	10.9

N: Normal R: Rectangular

Table 9 - Worst-Case uncertainty budget for HAC free field assessment



10 RF Emissions Tests

10.1 Emission Limits

Table 10.1 shows the M-rating criteria from ANSCI C63.19. All digital transmission modes in all frequency bands contained in a HAC phone must meet M3 or M4 levels.

Near		Wireless Device	RF Parameters	
Field		[AWF	= 0]	
Catagory	E-Field E	imissions	H-Field E	missions
Category	dB(V/m) Peak	V/m Peak	dB(A/m) Peak	V/m Peak
		Freq < 960 MHz	Z	
M1	56.0 to 61.0	631.0 to 1122.0	5.6 to 10.6	1.91 to 3.39
M2	51.0 to 56.0	354.8 to 631.0	0.6 to 5.6	1.07 to 1.91
М3	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07
M4	< 46.0	< 199.5	< -4.4	< 0.60
		Freq > 960 MHz	z	
M1	46.0 to 51.0	199.5 to 354.8	-4.4 to 0.6	0.60 to 1.07
M2	41.0 to 46.0	112.2 to 199.5	-9.4 to -4.4	0.34 to 0.60
М3	36.0 to 41.0	63.1 to 112.2	-14.4 to -9.4	0.19 to 0.34
M4	< 36.0	< 63.1	< -14.4	< 0.19

Table 10.1 - RF Emission Limits



10.2 CDMA 1900 Test Results

	CD	MA 1900 I	E-Field						
Configu	ıration:	At ear po	osition			Antenna	a Inter	rnal	
Ch.	Backlight	Battery	ВТ	Power before Test	Power after Test	Dasy4 Reading	PMF	Peak Field	Categor y
#				dBm	dBm	V/m		V/m	M
25	ON	Standard	OFF	22.30	22.4	18.40	1.00	18.40	4
600	ON	Standard	OFF	22.28	22.38	22.70	1.00	22.70	4
1175	ON	Standard	OFF	23.01	23.03	20.60	1.00	20.60	4
600	OFF	Standard	OFF	22.28	22.38	24.30	1.00	24.30	4
600 (360°)	ON	Standard	OFF	22.28	22.38	25.10	1.00	25.10	4
600	ON	Standard	ON	22.28	22.38	24.60	1.00	24.60	4

Data plots are shown in Appendix C

_	CD	MA 1900 I	H-Field						
Configu	ıration:	At ear po	osition			Antenna	a Inter	rnal	
Ch.	Backlight	Battery	ВТ	Power before Test	Power after Test	Dasy4 Reading	PMF	Peak Field	Categor y
#				dBm	dBm	A/m		A/m	M
25	ON	Standard	OFF	22.30	22.4	0.053	1.00	0.05	4
600	ON	Standard	OFF	22.28	22.38	0.082	1.00	0.08	4
1175	ON	Standard	OFF	23.01	23.03	0.074	1.00	0.07	4
600	OFF	Standard	OFF	22.28	22.38	0.080	1.00	0.08	4
600 (360°)	ON	Standard	OFF	22.28	22.38	0.082	1.00	0.08	4
600	ON	Standard	ON	22.28	22.38	0.082	1.00	0.08	4

Data plots are shown in Appendix C



10.3 CDMA 800 Test Results

_	CE	MA 800 E	-Field						
Configu	uration:	At ear po	osition			Antenna	a Inter	rnal	
Ch.	Backlight	Battery	ВТ	Power before Test	Power after Test	Dasy4 Reading	PMF	Peak Field	Categor y
#				dBm	dBm	V/m		V/m	М
1013	ON	Standard	OFF	24.90	24.92	54.60	1.00	54.60	4
383	ON	Standard	OFF	24.88	25.01	65.90	1.00	65.90	4
777	ON	Standard	OFF	24.80	24.90	60.20	1.00	60.20	4
383	OFF	Standard	OFF	24.88	25.01	63.00	1.00	63.00	4
383	ON	Standard	ON	24.88	25.01	62.70	1.00	62.70	4

Data plots are shown in Appendix C

	CD	MA 800 H	l-Field						
Configu	uration:	At ear po	osition			Antenna	a Inter	rnal	
Ch.	Backlight	Battery	ВТ	Power before Test	Power after Test	Dasy4 Reading	PMF	Peak Field	Categor y
#				dBm	dBm	A/m		A/m	M
1013	ON	Standard	OFF	24.90	24.92	0.083	1.00	0.08	4
383	ON	Standard	OFF	24.88	25.01	0.091	1.00	0.09	4
777	ON	Standard	OFF	24.80	24.90	0.089	1.00	0.09	4
383	OFF	Standard	OFF	24.88	25.01	0.086	1.00	0.09	4
383	ON	Standard	ON	24.88	25.01	0.092	1.00	0.09	4

Data plots are shown in Appendix C



10.4 Worst-Case Configuration Evaluation

10.4.1 Peak Reading 360° Probe Rotation at Azimuth axis

The probe was rotated 360° in the worst-case configuration. The rotation was performed at the location of maximum field strength in the included blocks.

			CDMA 1900	E-Field			
Config	juration:	At ear posi	tion	Antenna:	Interna	I	
Ch.	Backlight	Battery	Conducted Power	Peak Field	PMF	Peak Field	Category
#			dBm	V/m		V/m	M
600	ON	Standard	22.28	25.10	1.0	25.10	4

			CDMA 800	E-Field			
Config	juration:	At ear posi	tion	Antenna:	Interna	I	
Ch.	Backlight	Battery	Conducted Power	Peak Field	PMF	Peak Field	Category
#			dBm	V/m		V/m	M
383	ON	Standard	24.88	60.00	1.0	60.00	4

Data plots are shown in Appendix C





11 **Appendix A: Probe Calibration Certification**

X5583

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst S Service suisse d'étalonnage С Servizio svizzero di taratura S

Swiss Callbration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client

Kyocera USA

Certificate No: ER3-2341_Apr07

Accreditation No.: SCS 108

CALIBRATION	CERTIFICAT		性的機能指揮等對於
Object	ER3DV6 - SN:2	341	
Calibration procedure(s)	QA CAL-02.v5 Calibration proc evaluations in a	edure for E-field probes optimized for ir	close near field
Calibration date:	April 20, 2007		
Condition of the calibrated Item	In Tolerance		
The measurements and the unc	ertainties with confidence	tional standards, which realize the physical units of probability are given on the following pages and are ory facility: environment temperature (22 ± 3) °C and	e part of the certificate.
Calibration Equipment used (M&		, ,	
Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
ower meter E4419B	GB41293874	29-Mar-07 (METAS, No. 217-00670)	Mar-08
ower sensor E4412A	MY41495277	29-Mar-07 (METAS, No. 217-00670)	Mar-08
ower sensor E4412A	MY41498087	29-Mar-07 (METAS, No. 217-00670)	Mar-06
eference 3 dB Attenuator	SN: S5054 (3c)	10-Aug-06 (METAS, No. 217-00592)	Aug-07
teference 20 dB Altenuator	SN: S5086 (20b)	29-Mar-07 (METAS, No. 217-00671)	Mar-08
teference 30 dB Attenuator	SN: S5129 (30b)	10-Aug-06 (METAS, No. 217-00593)	Aug-07
Reference Probe ER3DV6	SN: 2328	2-Oct-06 (SPEAG, No. ER3-2328_Oct06)	Oct-07
DAE4	SN: 654	21-Jun-06 (SPEAG, No. DAE4-654_Jun06)	Jun-07
econdary Standards	ID#	Check Date (in house),	Scheduled Check
F generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Nov-05)	In house check: Nov-07
letwork Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Oct-06)	In house check: Oct-07
	Name	Function	Signature
alibrated by:	Kalja Pokovic	Technical Manager	Zhin Kily
approved by:	Niels Kuster	- Quality Manager	F. Ambelt
	Charle (NOON) Carefall (NO		





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Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurlch, Switzerland





Schweizerischer Kallbrierdienst Service sulsse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

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Client

Kyocera USA

Certificate No: H3-6029_Jun06

	班 三 美智县 三十八烷 医		《副科学》
CALIBRATION	SEKTIFICAT		SECULO DE PROPERTO DE LA COMPONIO D
Object	H3DV5 - SN:60	29	
Calibration procedure(s)	QA CAL-03.v4 Calibration proc evaluations in a		close near field
Calibration date:	June 22, 2006		
Condition of the calibrated item	In Tolerance		
The measurements and the unco	ertainties with confidence to the closed laborate	utional standards, which realize the physical units of probability are given on the following pages and are only facility: environment temperature $(22 \pm 3)^{\circ}$ C and	e part of the certificate.
		Cal Date (Calibrated by Cartificate No.)	Scheduleri Calibration
Primary Standards	ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Primary Standards Power meter E4419B	ID # GB41293874	5-Apr-05 (METAS, No. 251-00557)	Apr-07
Primary Standards Power meter E4419B Power sensor E4412A	ID # GB41293874 MY41495277	5-Apr-05 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557)	Apr-07 Apr-07
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A	ID # GB41293874 MY41495277 MY41498087	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557)	Apr-07 Apr-07 Apr-07
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c)	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499)	Apr-07 Apr-07 Apr-07 Aug-06
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b)	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-05 (METAS, No. 251-00558)	Apr-07 Apr-07 Apr-07 Aug-06 Apr-07
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b)	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-05 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500)	Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b)	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-05 (METAS, No. 251-00558)	Apr-07 Apr-07 Apr-07 Aug-06 Apr-07
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S6129 (30b) SN: 6182	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-05 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05)	Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-05 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 2-Feb-06 (SPEAG, No. DAE4-654_Feb08)	Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06 Feb-07
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8848C	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 6554	5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 5-Apr-05 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-05 (METAS, No. 251-00508) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 2-Feb-06 (SPEAG, No. DAE4-654_Feb06) Check Date (in house)	Apr-07 Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06 Feb-07 Scheduled Check
Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S6129 (30b) SN: 6162 SN: 6554 ID # US3642U01700	5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 2-Feb-06 (SPEAG, No. DAE4-654_Feb06) Check Date (in house) 4-Aug-99 (SPEAG, in house check Nov-05) 18-Oct-01 (SPEAG, in house check Nov-05)	Apr-07 Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Oct-06 Feb-07 Scheduled Check In house check: Nov-07
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8848C Network Analyzer HP 8753E	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654 ID # US3542U01700 US37390585	5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 2-Feb-06 (SPEAG, No. DAE4-654_Feb06) Check Date (in house) 4-Aug-99 (SPEAG, in house check Nov-05) 18-Oct-01 (SPEAG, in house check Nov-05)	Apr-07 Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Cct-06 Feb-07 Scheduled Check In house check: Nov-07 In house check: Nov 06
Primary Standards Power meter E4419B Power sensor E4412A Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8848C	ID # GB41293874 MY41495277 MY41498087 SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 654 ID # US3542U01700 US37390585 Name	5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 5-Apr-06 (METAS, No. 251-00557) 11-Aug-05 (METAS, No. 251-00499) 4-Apr-06 (METAS, No. 251-00558) 11-Aug-05 (METAS, No. 251-00500) 3-Oct-05 (SPEAG, No. H3-6182_Oct05) 2-Feb-06 (SPEAG, No. DAE4-654_Feb06) Check Date (in house) 4-Aug-99 (SPEAG, in house check Nov-05) 18-Oct-01 (SPEAG, in house check Nov-05)	Apr-07 Apr-07 Apr-07 Apr-07 Aug-06 Apr-07 Aug-06 Cct-06 Feb-07 Scheduled Check In house check: Nov-07 In house check: Nov 06





12 Appendix B: System Validation Plots

(See attachment)

13 Appendix C: Test Results/Plots

(See attachment)

14 Appendix D: Photo Test Setup

(see attachment)